PHK13N03LT

N-channel TrenchMOS logic level FET

Rev. 02 — 17 March 2009

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Simple gate drive required due to low gate charge
- Suitable for high frequency applications due to fast switching characteristics

1.3 Applications

- DC-to-DC convertors
- Lithium-ion battery applications
- Notebook computers
- Portable equipment

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}$	-	-	30	V
I_D	drain current	$T_{sp} = 25 ^{\circ}\text{C}; V_{GS} = 10 \text{V};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	13.8	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 2</u>	-	-	6.25	W
Dynamic characteristics						
Q_{GD}	gate-drain charge	$V_{GS} = 5 \text{ V}; I_D = 8 \text{ A};$ $V_{DS} = 15 \text{ V}; T_j = 25 \text{ °C};$ see Figure 11	-	3.9	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 8 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 9}}{\text{see } \frac{\text{Figure 10}}{\text{odd}}};$	-	17	20	mΩ



2 of 12

Pinning information

Pinning information Table 2.

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source	8 <u>7 7 7 7</u> 5	D
3	S	source		$G \longrightarrow A$
4	G	gate		
5	D	drain	1 1 1 1 14	mbb076 S
6	D	drain	SOT96-1	
7	D	drain	(SO8)	
8	D	drain		

Ordering information 3.

Table 3. **Ordering information**

Type number	Package		
	Name	Description	Version
PHK13N03LT	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

Limiting values

Table 4. **Limiting values**

Product data sheet

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	30	V
V_{DGR}	drain-gate voltage	$T_j \ge 25$ °C; $T_j \le 150$ °C; $R_{GS} = 20$ kΩ	-	30	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	$T_{sp} = 25 ^{\circ}\text{C}$; $V_{GS} = 10 \text{V}$; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	13.8	А
		T _{sp} = 100 °C; V _{GS} = 10 V; see <u>Figure 1</u>	-	8.7	А
I _{DM}	peak drain current	T_{sp} = 25 °C; $t_p \le 10 \mu s$; pulsed; see Figure 3	-	55	А
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 2</u>	-	6.25	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dr	ain diode				
I _S	source current	$T_{sp} = 25 ^{\circ}\text{C}$	-	5.7	Α
I _{SM}	peak source current	T_{sp} = 25 °C; $t_p \le 10 \mu s$; pulsed	-	55	А

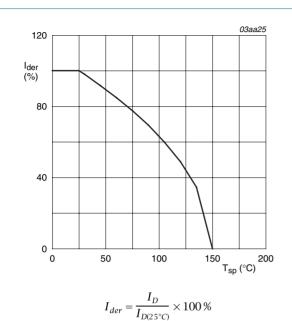
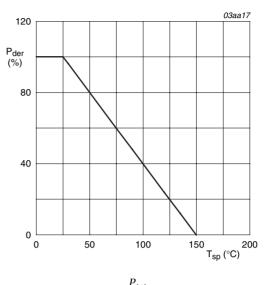
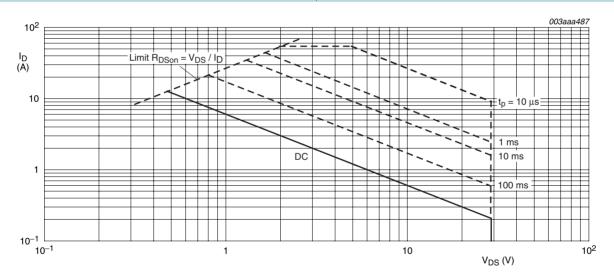


Fig 1. Normalized continuous drain current as a function of solder point temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of solder point temperature



 $T_{mb} = 25 \,^{\circ}C; I_{DM}$ is single pulse

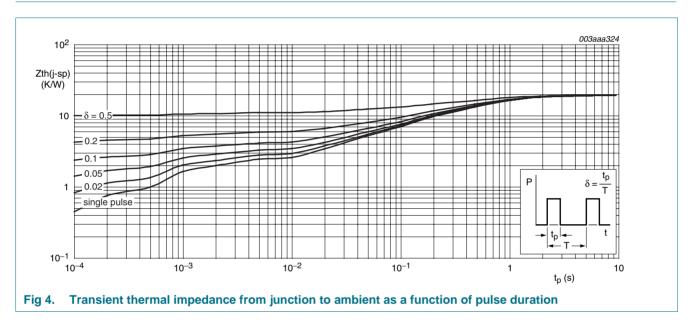
Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

3 of 12

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-	-	20	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	70	-	K/W



6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
	breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 250 μ A; V_{DS} = V_{GS} ; T_j = 150 °C; see <u>Figure 8</u>	0.5	-	-	V
		$I_D = 250 \mu A$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 8	-	-	2.2	V
		$I_D = 250 \mu A$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see Figure 8	1	1.5	2	V
I _{DSS}	drain leakage current	$V_{DS} = 24 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 24 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 100 \text{ °C}$	-	-	5	V V V
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nΑ
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nΑ
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 7 \text{ A}; T_j = 25 \text{ °C};$ see Figure 9	-	21	26 33 20	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 8 \text{ A}; T_j = 150 ^{\circ}\text{C};$ see <u>Figure 10</u> ; see <u>Figure 9</u>	-	-		mΩ
		$V_{GS} = 10 \text{ V}; I_D = 8 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 9</u> ; see <u>Figure 10</u>	-	17		mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 8 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 5 \text{ V};$	-	10.7	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 11</u>	-	2.7	-	nC
Q_{GD}	gate-drain charge		-	3.9	-	nC
C _{iss}	input capacitance	$V_{DS} = 15 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	752	-	pF
Coss	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	200	-	pF
C _{rss}	reverse transfer capacitance		-	130	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 15 \text{ V}; R_L = 10 \Omega; V_{GS} = 10 \text{ V}; R_{G(ext)} = 6 \Omega; T_j = 25 \text{ °C}; I_D = 1.5 \text{ A}$	-	6	-	ns
t _r	rise time	$V_{DS} = 15 \text{ V}; R_L = 10 \Omega; V_{GS} = 10 \text{ V}; R_{G(ext)} = 6 \Omega; I_D = 1.5 \text{ A}; T_j = 25 °C$	-	7	-	ns
t _{d(off)}	turn-off delay time	$V_{DS} = 15 \text{ V}; R_L = 10 \Omega; V_{GS} = 10 \text{ V};$	-	23	-	ns
t _f	fall time	$R_{G(ext)} = 6 \Omega; T_j = 25 \text{ °C}; I_D = 1.5 A$	-	11	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 7 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see <u>Figure 13</u>	-	0.86	1.1	V
t _{rr}	reverse recovery time	$I_S = 7 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	25	-	ns
Q _r	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	5	-	nC

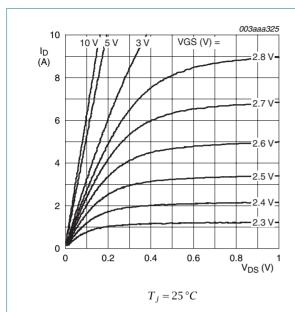
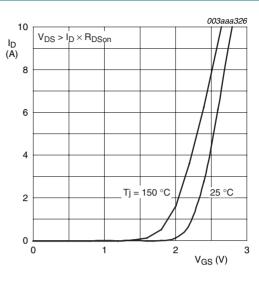
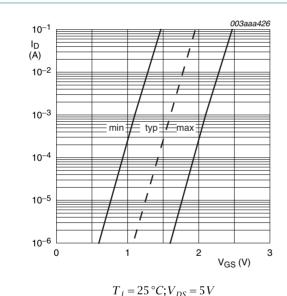


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



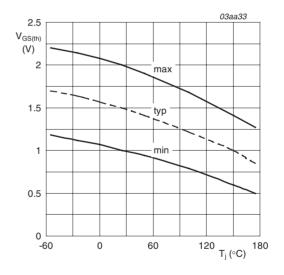
 $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



ig 7. Sub-threshold drain current as a function of

gate-source voltage



 $I_D = 1 \, mA; V_{DS} = V_{GS}$

Fig 8. Gate-source threshold voltage as a function of junction temperature

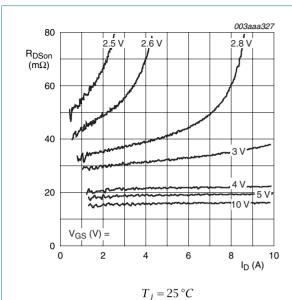


Fig 9. Drain-source on-state resistance as a function of drain current; typical values

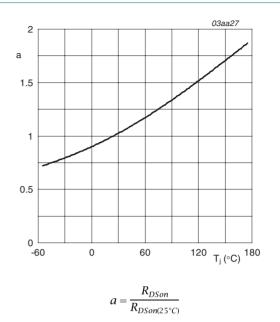


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature

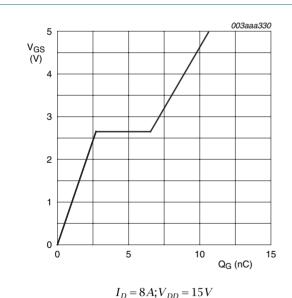
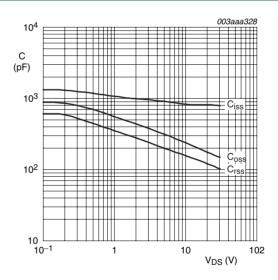


Fig 11. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7 of 12

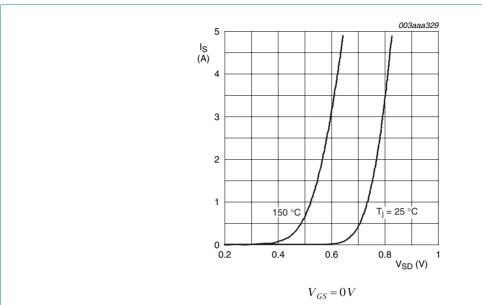
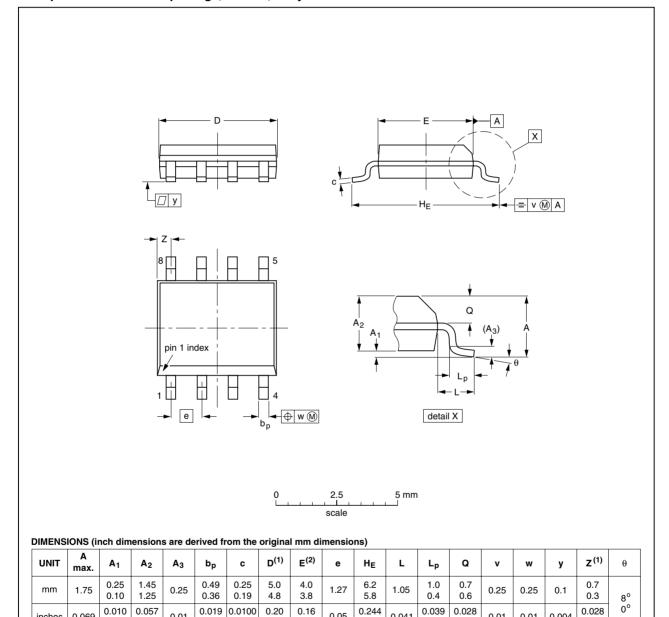


Fig 13. Source current as a function of source-drain voltage; typical values

Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



inches

0.069

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

0.014 0.0075

0.01

2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT96-1	076E03	MS-012			99-12-27 03-02-18

0.05

0.041

0.016

0.024

0.228

0.004

0.01

0.01

Fig 14. Package outline SOT96-1 (SO8)

0.004

0.049



8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHK13N03LT_2	20090317	Product data sheet	-	PHK13N03LT-01
Modifications:	Modifications: • The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.			ly with the new identity
	 Legal text 	s have been adapted to th	ne new company name v	where appropriate.
PHK13N03LT-01	20030623	Product data sheet	-	-



9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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11. Contents

1	Product profile	1
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	1
1.4	Quick reference data	1
2	Pinning information	2
3	Ordering information	2
4	Limiting values	2
5	Thermal characteristics	4
6	Characteristics	5
7	Package outline	9
8	Revision history	10
9	Legal information	
9.1	Data sheet status	11
9.2	Definitions	11
9.3	Disclaimers	11
9.4	Trademarks	11
10	Contact information	11

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